S	earch	ı Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,298	PHAN ET AL.	
Examiner	Art Unit	
Theo Y Lo	2014	

	SEARCHED			
Class	Subclass	Date	Examiner	
257	718, 706 720, 675 625,276 717	10/1/2005	TL	
361	274,697	10/1/2005	TL	
361	702,709	10/1/2005	TL	
361	514,696	10/1/2005	TL	
174	16.3	10/1/2005	TL	
228	222	10/1/2005	TL	
438	122	10/1/2005	TL	
Update	Search	12/27/2005	TL	
Update	Search	4/30/2006	TL	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEAF (INCLUDING S	RCH NOTES EARCH STR	ATEGY	
		DATE	EXMR
See print out	10)/1/2005	TL
See print out	12.	/27/2005	ΤL
See print out	4/	30/2006	TL
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